October 2001

# FDS6894A

## Dual N-Channel Logic Level PWM Optimized PowerTrench<sup>®</sup> MOSFET

## **General Description**

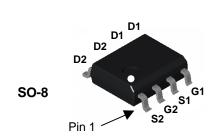
These N-Channel Logic Level MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

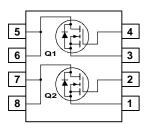
These devices are well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

## Features

• 8 A, 20 V.

- Low gate charge (17 nC)
- High performance trench technology for extremely low  $R_{\text{DS}(\text{ON})}$
- High power and current handling capability





## Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted

Symbol		Parameter		Ratings	Units
V <sub>DSS</sub>	Drain-Sourc	e Voltage		20	V
V <sub>GSS</sub>	Gate-Source	e Voltage		± 8	V
ID	Drain Current – Continuous (Note 1a)		(Note 1a)	8	А
	– Pulsed			32	
P <sub>D</sub>	Power Dissipation for Dual Operation			2	W
	Power Dissi	pation for Single Operatior	n (Note 1a)	1.6	
			(Note 1b)	1	
			(Note 1c)	0.9	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range			-55 to +150	°C
Therma	I Charact	eristics			
$R_{\theta JA}$	Thermal Res	sistance, Junction-to-Ambi	ent (Note 1a)	78	°C/W
R <sub>0JC</sub>	Thermal Res	Resistance, Junction-to-Case (Note		40	°C/W
Packag	e Marking	g and Ordering l	nformation		
Device Marking		Device	Reel Size	Tape width	Quantity
FDS6894A		FDS6894A	13"	12mm	2500 units

©2001 Fairchild Semiconductor Corporation

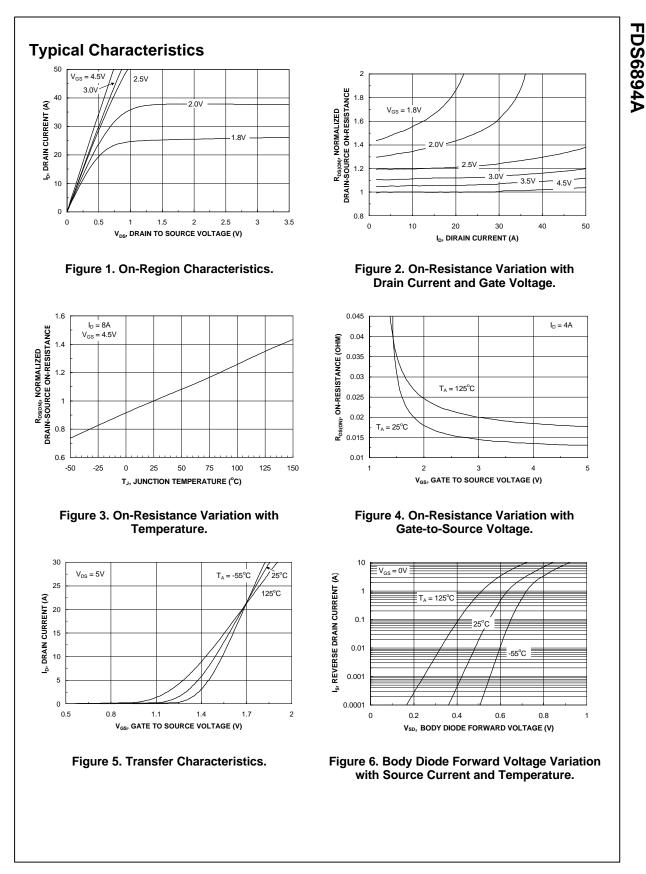
FDS6894A

Off Char	Parameter	Test Conditions	Min	Тур	Max	Units
	acteristics					
BV <sub>DSS</sub>	Drain–Source Breakdown Voltage	$V_{GS} = 0 V$ , $I_D = 250 \mu A$	20			V
$\Delta BV_{DSS}$ $\Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu$ A, Referenced to 25°C		13		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current				1 10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 8 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	nA
I <sub>GSSR</sub>	Gate–Body Leakage, Reverse	$V_{GS} = - 8 \text{ V},  V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)					
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$	0.6	0.8	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu\text{A}$ , Referenced to $25^{\circ}\text{C}$		-3		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$ \begin{array}{l} V_{GS} = 4.5 \; V,  I_D = 8 \; A \\ V_{GS} = 2.5 \; V,  I_D = 7 \; A \\ V_{GS} = 1.8 \; V,  I_D = 6 \; A \\ V_{GS} = 4.5 \; V, \; I_D = 8 \; A, T_J = 125^\circ C \end{array} $		13 16 21 18	17 20 30 25	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 4.5 V,  V_{DS} = 5 V$	16			Α
<b>g</b> fs	Forward Transconductance	$V_{DS} = 5 \text{ V}, \qquad I_D = 8 \text{ A}$		44		S
Dvnamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 10 \text{ V},  V_{GS} = 0 \text{ V},$		1676		pF
C <sub>oss</sub>	Output Capacitance	f = 1.0 MHz		288		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			146		pF
Switchin	g Characteristics (Note 2)	-		1	1	
t <sub>d(on)</sub>	Turn–On Delay Time	$V_{DD} = 10 V$ , $I_D = 1 A$ ,		10	20	ns
t <sub>r</sub>	Turn–On Rise Time	$V_{GS} = 4.5 \text{ V},  R_{GEN} = 6 \Omega$		14	25	ns
t <sub>d(off)</sub>	Turn–Off Delay Time			33	53	ns
t <sub>f</sub>	Turn–Off Fall Time	-		12	22	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 10 \text{ V},  I_D = 8 \text{ A},$		17	24	nC
Q <sub>gs</sub>	Gate–Source Charge	V <sub>GS</sub> = 4.5 V		2.8		nC
Q <sub>gd</sub>	Gate–Drain Charge	7		3.3		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain–Source				1.3	Α
8	Drain–Source Diode Forward Voltage	$V_{GS} = 0 V$ , $I_S = 1.3 A$ (Note 2)		0.7	1.2	V

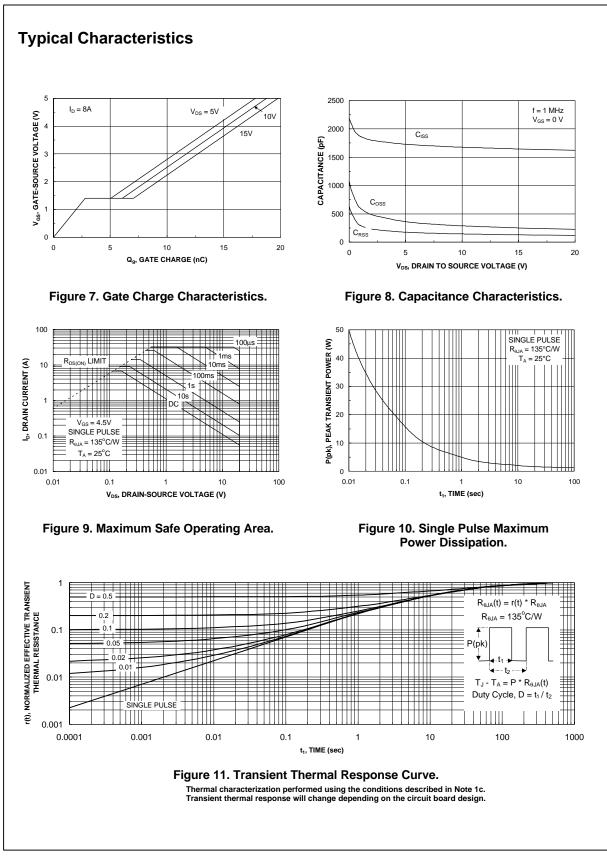
Scale 1 : 1 on letter size paper

**2.** Pulse Test: Pulse Width < 300 $\mu$ s, Duty Cycle < 2.0%

FDS6894A Rev C (W)



FDS6894A Rev C (W)



FDS6894A

FDS6894A Rev C (W)

#### TRADEMARKS

The following are registered and unregistered trademarks Fairchild Semiconductor owns or is authorized to use and is not intended to be an exhaustive list of all such trademarks.

ACEx™ Bottomless™ CoolFET™ CROSSVOLT™ DenseTrench™ DOME™ **EcoSPARK™** E<sup>2</sup>CMOS<sup>™</sup> EnSigna™ FACT™ FACT Quiet Series™ FAST ® FASTr™ FRFET™ GlobalOptoisolator<sup>™</sup> POP<sup>™</sup> GTO™ HiSeC™ ISOPLANAR™ LittleFET™ MicroFET™ MicroPak™ MICROWIRE™

**OPTOLOGIC™** OPTOPLANAR™ PACMAN™ Power247™ PowerTrench<sup>®</sup> QFET™ QS™ QT Optoelectronics<sup>™</sup> Quiet Series<sup>™</sup> SILENT SWITCHER®

SMART START™ VCX™ STAR\*POWER™ Stealth™ SuperSOT<sup>™</sup>-3 SuperSOT<sup>™</sup>-6 SuperSOT<sup>™</sup>-8 SyncFET™ TinyLogic™ TruTranslation<sup>™</sup> UHC™ UltraFET<sup>®</sup>

STAR\*POWER is used under license

### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY. FUNCTION OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

## LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, or (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in significant injury to the user.

2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

#### **PRODUCT STATUS DEFINITIONS**

**Definition of Terms** 

Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice.			
First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.			
Full Production	This datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.			
Not In Production	This datasheet contains specifications on a product that has been discontinued by Fairchild semiconductor. The datasheet is printed for reference information only.			
	In Design First Production Full Production			